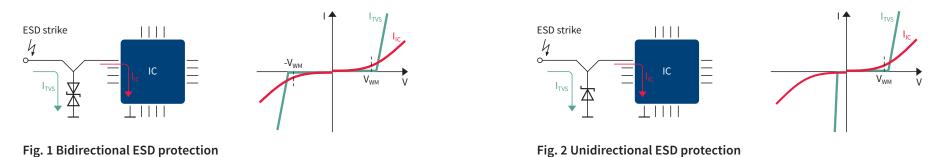


Understanding ESD protection device characteristics

Basic introduction



Basic application examples



Bidirectional ESD protection devices are symmetric (fig. 1). They can be used on the lines with bipolar signals ($-V_{WM} \le V_{signal} \le V_{WM}$) as well as with unipolar signals ($0 \le V_{signal} \le V_{WM}$).

Unidirectional ESD protection devices (fig. 2) are asymmetric, and can be used on lines with unipolar signals only ($0 \le V_{signal} \le V_{WM}$). Physically they are used in reverse direction, analogous to Zener diodes. The convention across the industry is to specify voltage and current in that direction as positive, like the voltages in the application.

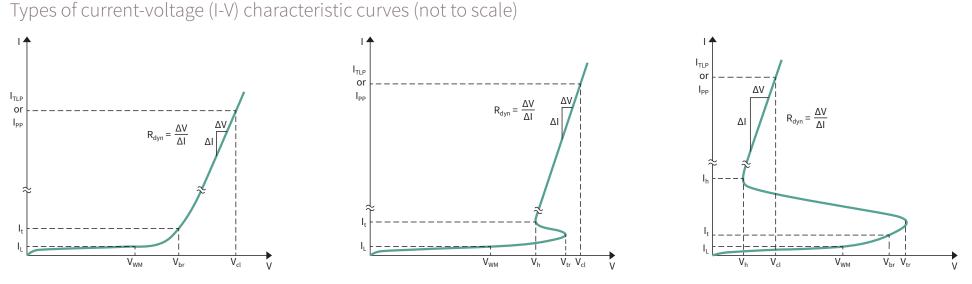
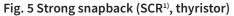


Fig. 3 Diode-like

Fig. 4 Mild snapback



1) SCR = Silicon controlled rectifier

Current-voltage (I-V) characteristic summary

I-V behaviour type	Features and benefits	Best suited for			
Diode-like	 > Simple behavior, easy to use > Good protection performance > Low voltage overshoot, fast turn-on 	 > Fast turn-on applications > Multi-purpose and low speed applications: buttons, switches, audio, GPIO, touch panels 			
Mild snapback	 > Improved protection performance (V_{cl}) > Enables low capacitance (C_L) > Excellent balance of V_{WM} and V_{cl} 	Same applications as diode-like, plus High speed I/O and RF applications 			
Strong snapback (SCR, thyristor) * "Pound for pound" best protection performance (V _{el}) Enables low capacitance (C _L)		 > RF applications > Applications with most demanding V_{cl} requirement - High speed applications, LVDS - Super fine geometry SoC I/O with nm-scale technology 			

Typical first order selection parameters for the TVS

C_L – line capacitance – especially important for high speed/RF applications, less so for general purpose and low speed applications.

 V_{WM} – maximum working voltage – must be chosen equal or higher than the maximum voltage on the protected line during specified operation (see fig. 6). Typical protection devices have V_{WM} aligned with standard system and I/O voltages (V_{IO} , V_{bus}), i.e. 2.1 V, 3.3 V, 5 V.

 V_{cl} – clamping voltage – the most important parameter for protection performance. At the given stress level $(I_{TLP}, I_{PP})^{1} V_{cl}$ must be lower than the failure voltage of the IC (if known), otherwise as low as possible.



Fig. 6 V_{WM} equal or higher than V_{signal}

I-V curve parameters for advanced understanding

V_h, I_h – holding voltage, holding current

- > For strong snapback devices $V_h < V_{WM}$. V_h is a local minimum of the voltage, and I_h is the corresponding current. V_h and I_h must be balanced with the line driver DC voltage/ current capability in order to prevent a device latch-up²).
- > For mild snapwback devices $V_h > V_{WM}$. I_h is not given in the datasheet, V_h is measured at a fixed testing current I_t .
- V_{br} breakdown voltage measured at specified testing current I_t

 V_{tr} – trigger voltage - maximum voltage before the device turns on (triggers) and snaps back to V_{h} . For snapback devices V_{tr} is slightly higher than V_{br} . V_{tr} is verified by design.

 $I_{\rm L}$ – $leakage\ current$ – current that flows through the device at $V_{_{WM}}$

 R_{dyn} – dynamic resistance – characterizes the steepness of the device I-V characteristic while conducting an ESD event³⁾. Lower R_{dyn} is usually related to better protection performance, can be used to estimate V_{cl} at different stress levels (I_{TLP}) than datasheet provides.

Other device parameters/characteristics

Linearity – in applications with RF transmitters, e.g. mobile phones, EMI/EMC can be a concern due to harmonic generation from ESD protection devices on signal lines. ESD protection devices optimized for linearity generate less harmonic distortion and intermodulation.

IL - insertion loss - correlates highly with C_L, important only for high-speed/RF applications

V_{ESD} - maximum electrostatic discharge voltage - based on IEC61000-4-2

I_{PP} – maximum pulse current – also referred to as surge robustness, based on IEC61000-4-5

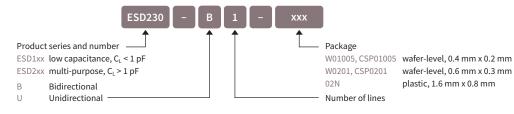
1) V_{cl} depends on the pulse width and shape: TLP, IEC61000-4-2, IEC61000-4-5 2) <u>AN525</u>: Latch-up prediction for SCR TVS device 3) Measured using Transmission Line Pulse (TLP) system

Low capacitance ESD protection devices

Product name	C _L typical [pF]	V _{wм} [V]	V _{cl} typical @ I _{TLP} = 16 A [V]	l _L max [nA]	R _{dyn} typical [Ω]	V _{ESD} ¹⁾ contact [kV]	I _{PP} ²⁾ 8/20 μs [A]	Availability
ESD106-B1-W0201	0.13	5.5	25.0	20	1.10	14	1.5	Mass production
ESD107-U1-W0201	0.50	3.3	12.5/4.0 ³⁾	50	0.40/0.203)	20	3.0	In planning
ESD108-B1-CSP0201	0.28	5.5	20.0	20	0.78	25	2.5	Mass production
ESD119-B1-W01005	0.20	5.5	20.0	20	0.80	25	2.5	Mass production
ESD120-B1-W0201	0.25	2.1	19.0	200	0.94	15	-	Development
ESD121-B1-W0201	0.25	7.0	24.0	200	0.90	15	-	In planning
ESD128-B1-W0201	0.30	18.0	32.0	30	0.85	15	2.0	Mass production
ESD129-B1-W01005	0.30	18.0	32.0	30	0.82	15	2.0	Mass production
ESD130-B1-W0201	0.30	5.5	20.0	20	0.80	18	2.5	Mass production
ESD131-B1-W0201	0.23	5.5	13.0	100	0.66	20	3.5	Mass production
ESD132-B1-W0201	0.45	5.5	7.0	100	0.20	30	9.0	Mass production
ESD133-B1-W01005	0.20	5.5	13.0	50	0.56	20	3.0	Mass production
ESD134-B1-W0201	0.30	2.1	7.7	20	0.28	28	7.5	Mass production
ESD144-B1-W0201	0.20	18.0	12.5	50	0.58	18	3.5	Mass production
ESD145-B1-W01005	0.20	18.0	12.5	50	0.58	18	3.5	Mass production

Product name V_{cl} typical Availability C₁ typical V_{wм} I₁ max R_{dvn} typical V_{ESD}¹⁾ 8/20 µs @ I_{TLP} = 16 A contact [pF] ESD200-B1-CSP0201 6.5 5.5 13.0 100 0.20 17 3.0 Mass production ESD202-B1-CSP01005 6.5 5.5 13.0 100 0.20 15 3.0 Mass production ESD230-B1-W0201 7.0 5.5 13.0 100 0.22 16 3.0 Mass production ESD231-B1-W0201 3.5 5.5 12.0 20 0.30 30 12.0 Mass production ESD233-B1-W0201 33.0 5.5 13.0 100 0.20 20 5.0 Mass production 5.5 ESD234-B1-W0201 56.0 12.5 100 0.15 19 7.0 Mass production 8.0 16 3.0 ESD237-B1-W0201 7.0 13.0 100 0.21 Mass production ESD239-B1-W0201 3.2 22.0 27.0 100 0.27 16 3.0 Mass production ESD240-B1-W01005 3.0 22.0 27.0 100 0.31 16 3.0 Development ESD241-B1-W0201 6.5 3.3 30 0.09 18 4.5 Mass production 6.0 ESD242-B1-W01005 4.5 6.0 3.3 6.0 30 0.09 18 Mass production ESD245-B1-W0201 5.8 5.5 7.5 30 0.10 15 5.5 Mass production ESD246-B1-W01005 5.5 5.5 7.5 30 0.10 15 5.5 Mass production 18.0 23.5 0.27 3.0 ESD249-B1-W0201 4.2 100 16 Mass production ESD251-B1-W0201 33.0 3.3 6.0 100 0.09 25 8.0 Development 3.3 6.0 100 0.09 25 8.0 ESD252-B1-W01005 33.0 Development ESD253-B1-W0201 24.0 31.0 100 0.30 15 3.0 2.8 Mass production 24.0 32.0 0.35 15 3.0 ESD254-B1-W01005 2.5 100 Development ESD259-B1-W0201 4.2 16.0 24.0 500 0.29 15 2.5 Mass production 30 ESD307-U1-02N 270.0 10.0 17.0/2.03) 100 0.05/0.053) 34.0 Mass production ESD311-U1-02N 210.0 15.0 22.0/2.0³⁾ 100 0.07/0.053) 30 28.0 Mass production

Nomenclature – Sales number



1) V_{ESD} based on IEC61000-4-2, contact discharge 2) I_{PP} based on IEC61000-4-5, 8/20 µs current waveform 3) Positive/negative direction

Multi-purpose ESD protection devices

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